

<b>Notice of References Cited</b>	Application/Control No. 10/035,897		Applicant(s)/Patent Under Reexamination TEN-HOVE ET AL.	
	Examiner Nadeem Iqbal		Art Unit 2114	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-2002/0120918 A1	08-2002	Aizenbud-Reshef et al.	717/127
X	B	US-2003/0078906 A1	04-2003	Ten-Hove et al.	707/1
X	C	US-5,533,192 A	07-1996	Hawley et al.	714/28
X	D	US-5,794,047 A	08-1998	Meier, Michael S.	717/133
X	E	US-6,042,614 A	03-2000	Davidson et al.	717/116
X	F	US-6,668,369 B1	12-2003	Krebs et al.	717/125
X	G	US-5,819,093 A	10-1998	Davidson et al.	717/126
X	H	US-6,253,317 B1	06-2001	Knapp et al.	712/244
X	I	US-6,480,818 B1	11-2002	Alverson et al.	703/26
X	J	US-2002/0120919 A1	08-2002	Aizenbud-Reshef et al.	717/127
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.